CT/FCT TEST PROBES

Spring-loaded test probe GKS-075 217 120 A 1000

Item GKS-075-0048



- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- Various spring forces available as well as versions with stainless steel springs suitable for high temperatures

General data

Product aroup ICT / FCT (in-circuit test and function test Sub-product group Standard stroke test probe Series GKS-075 Grid 1.91 mm [75 mil] Contacting from Pad, Via, Female connector Magnetic Installation type Plug-in Quick-exchange system Yes Adjustable installation height No Non-rotating No KS-075 Compatible receptacle(s) - 40 °C [- 104 °F] Min. temperature Max. temperature + 80 °C [+ 176 °F] RoHS-compliant RoHS-3;6a



Electrical data

Current load capacity / rated current 3 A
Typical resistance (Ri) <20 mOhm



 Total length
 33.1 mm [1.30 in]

 Barrel diameter
 1.02 mm [.040 in]

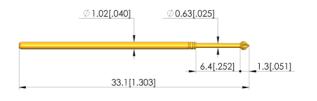
 Maximum stroke
 6.35 mm [.25 in]

 Spring pre-load
 0.4 N [1.43 ozf]

 Collar height
 00

 Spring force at working stroke
 1 N [3.59 ozf]

 Recommended working stroke
 4.3 mm [.169 in]





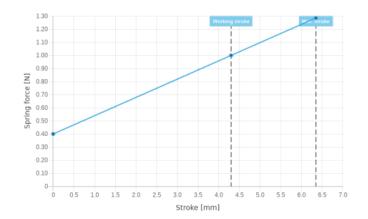
Tip style data

Tip style 17 hexagonal pyramid with cutting edges, self-cleaning
Tip diameter 1.2 mm [.047 in]
Tip style surface A gold
Tip style material 2 steel

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Learn more about ICT/FCT Test probes

